Power MOSFET

30 V, 31 A, Single N-Channel, SO-8 Flat Lead

Features

- Low R_{DS(on)}
- Optimized Gate Charge
- Low Inductance SO-8 Package
- These are Pb-Free Devices

Applications

- Notebooks, Graphics Cards
- DC-DC Converters
- Synchronous Rectification

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current	Steady	$T_A = 25^{\circ}C$	I _D	18	Α
(Note 1)	State	$T_A = 85^{\circ}C$		13	
	$t \le 10 s$	$T_A = 25^{\circ}C$		31	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	2.2	W
	$t \le 10 s$			6.9	
Continuous Drain Current	Steady State	T _A = 25°C	I _D	11	А
(Note 2)		T _A = 85°C		8.0	
Power Dissipation (Note 2)		T _A = 25°C	PD	0.9	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	94	А
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 150	°C
Source Current (Body Diode)			۱ _S	7.0	А
Single Pulse Drain-to-Source Avalanche Energy (V _{DD} = 30 V, V _{GS} = 10 V, I _{PK} = 30 A, L = 1 mH, $R_G = 25 \Omega$)			E _{AS}	450	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Value	Unit
Junction-to-Case - Steady State		1.7	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	55.8	
Junction-to-Ambient – t \leq 10 s (Note 1)	R _{0JA}	18	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	139.1	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface mounted on FR4 board using 1 in sq pad size

(Cu area = 1.127 in sq [1 oz] including traces).

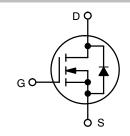
2. Surface mounted on FR4 board using the minimum recommended pad size (Cu area = 1.0 in sq).

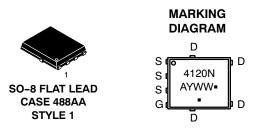


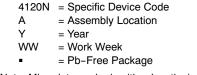
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} Typ	I_D Max (Note 1)
30 V	3.5 mΩ @ 10 V	31 A
50 V	4.2 mΩ @ 4.5 V	







(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4120NT1G	SO-8 FL (Pb-Free)	1500 Tape & Reel
NTMFS4120NT3G	SO-8 FL (Pb-Free)	5000 Tape & Reel

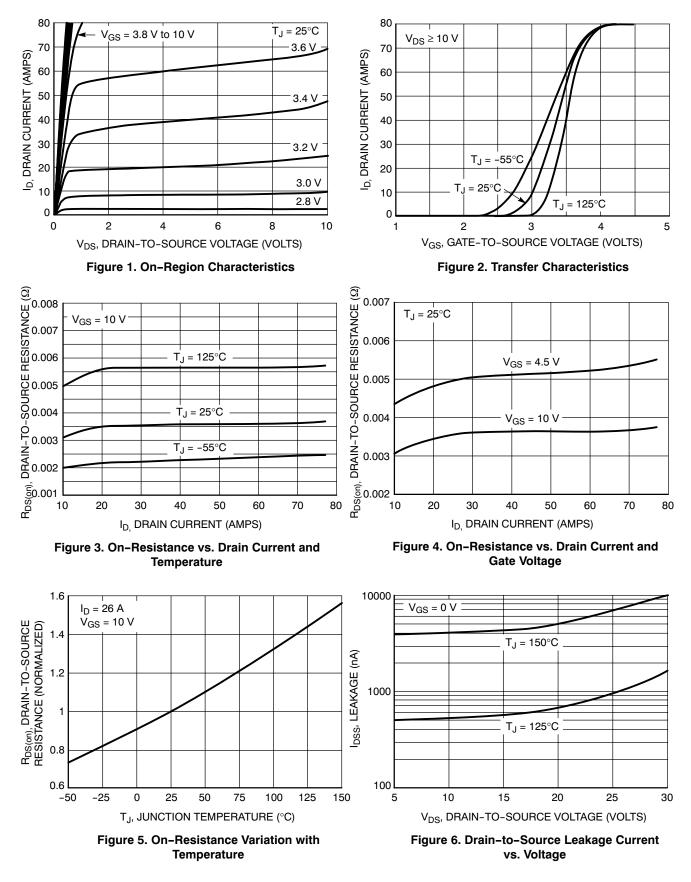
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

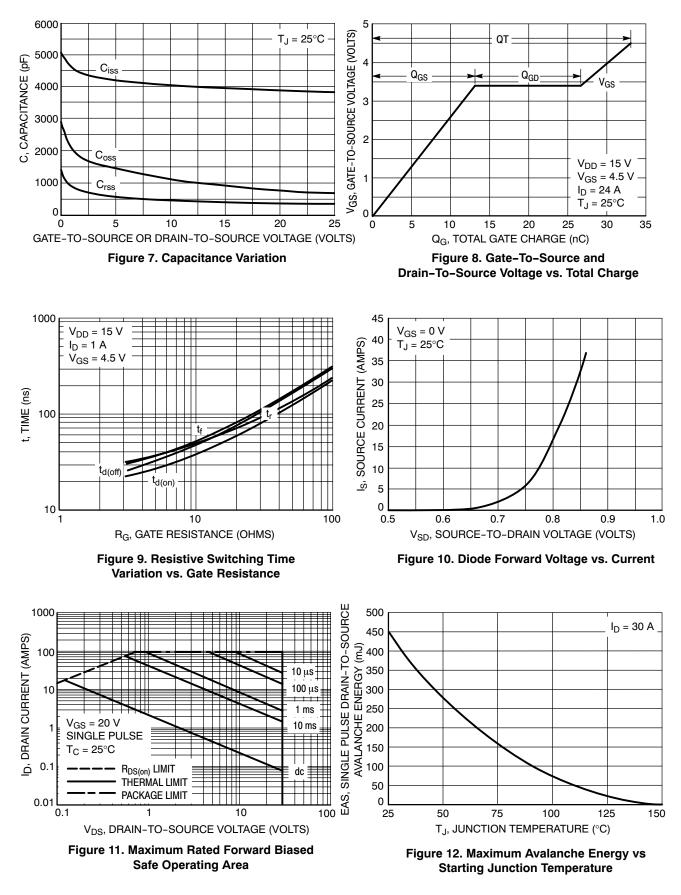
Characteristic	Symbol	Test Conditi	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		30			V
Drain-to-Source Breakdown Voltage erfiperature Coefficient	V _{(BR)DSS} /T _J				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V_{GS} = 0 V, V_{DS} = 24 V	$T_J = 25^{\circ}C$			1.0	μΑ
			T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μA	1.0		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				7.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 26 A			3.5	4.5	mΩ
		V _{GS} = 4.5 V, I _D = 24 A			4.2	5.5	
Forward Transconductance	9 FS	V _{DS} = 15 V, I _D = 26 A			35		S
CHARGES, CAPACITANCES AND GATE R	ESISTANCE						
Input Capacitance	C _{ISS}				3600		pF
Output Capacitance	C _{OSS}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 24 V			640		
Reverse Transfer Capacitance	C _{RSS}				380		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 24 A			33	50	nC
Threshold Gate Charge	Q _{G(TH)}				4.4		-
Gate-to-Source Charge	Q _{GS}				13		
Gate-to-Drain Charge	Q _{GD}				14		
Gate Resistance	R _G				1.0		Ω
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}				24		ns
Rise Time	t _r	Vcs = 4.5 V. Vcs	= 15 V.		32		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I _D = 1.0 A, R _G = 3.0 Ω			27		
Fall Time	t _f				31		
DRAIN-SOURCE DIODE CHARACTERISTI	cs						
Forward Diode Voltage	V _{SD}	V_{GS} = 0 V, I _S = 6.0 A	$T_J = 25^{\circ}C$		0.74	1.0	V
-			T _J = 125°C		0.6		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 6.0 A			36		ns
Charge Time	t _a				18		1
Discharge Time	t _b				18		1
Reverse Recovery Charge	Q _{RR}				34		nC

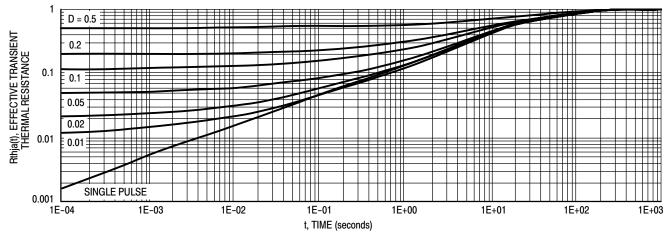
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

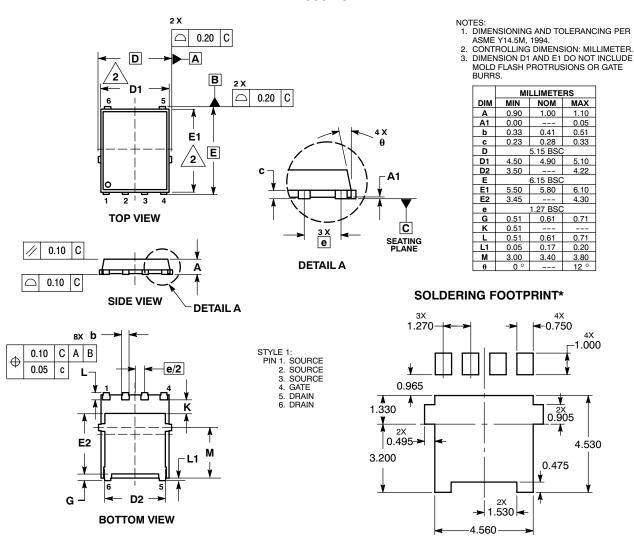






PACKAGE DIMENSIONS

DFN6 5x6, 1.27P (SO8 FL) CASE 488AA-01 ISSUE C



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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